

RoHS Compliant

Anti-Sulfuration PCI Express Flash Drive

PV220-M280 Product Specifications



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Specifications Overview:

PCIe Interface

- Compliant with PCIe Express 3.1
- Compliant with NVMe 1.3
- Compatible with PCle Gen3 x4 interface

Capacity

- Single side: 120 GB
- Double side: 240, 480, 960, 1,920 GB

Performance*

- Interface burst read/write: 4 GB/sec
- Sequential read: up to 1,710 MB/sec
- Sequential write: up to 1,685 MB/sec
- Random read (4K): up to 222,000 IOPS
- Random write (4K): up to 263,000 IOPS

Flash Management

- Low-Density Parity-Check (LDPC) Code
- Global Wear Leveling
- Flash bad-block management
- Flash Translation Layer: Page Mapping
- S.M.A.R.T.
- DataDefender™
- TRIM
- Hyper Cache Technology
- Over-Provisioning
- DataRAID™
- NVMe Secure Erase

NAND Flash Type: 3D TLC (BiCS3)

MTBF: >3,000,000 hours

Endurance (in drive writes per day: DWPD)

- 120 GB: 3.45 DWPD

- 240 GB: 3.09 DWPD

480 GB: 2.83 DWPD

960 GB: 2.9 DWPD

1,920 GB: 2.81 DWPD

Temperature Range

- Operating:

Standard: 0°C to 70°C Wide: -40°C to 85°C

Storage: -40°C to 100°C

Supply Voltage

 $-3.3 \text{ V} \pm 5\%$

Power Consumption*

- Active mode: 1,320 mA

Idle mode: 245 mA

Connector Type

- 75-pin M.2 module pinout

Power Management

- Supports APST
- Supports ASPM L1.2

NVMe Features**

- Supports HMB (Host Memory Buffer)

Security

AES 256-bit hardware encryption

Reliability

- Thermal Sensor
- Thermal Throttling
- End-to-End Data Protection
- CoreGlacier^{TM***}
- Anti-Sulfuration

Form Factor

Form Factor: M.2 2280-D5-M Key

- Dimensions:

Single side: 22.00 x 80.00 x 2.58, unit: mm Double side: 22.00 x 80.00 x 4.08, unit: mm

Net Weight: 7.7g ± 5%

LED Indicators for Drive Behavior

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^{*}Varies from capacities. The values for performances and power consumptions presented are typical and may vary depending on flash

configurations or platform settings.
**Windows 10 (version 1703) onwards supports the HMB (Host Memory Buffer) function.

^{***}Only supported on wide temperature series

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1. General Descriptions

Apacer PV220-M280 is the fastest SSD designed as M.2 2280 mechanical dimensions, providing full compliance with PCIe Gen3 x4 interface and NVMe 1.3 specifications. Built with a powerful PCIe controller, PV220-M280 delivers outstanding performance in data transfer, reaching up to 222,000/263,000 and 1,710/1,685 MB/s in IOPS and sequential read/write. The extreme thin and light form factor makes PV220-M280 the ideal choice for mobile computing systems, which appears to be the trend in near future.

Featuring anti-sulfuration technology, PV220-M280 not only uses special alloy materials but also achieves a complete air barrier through rigorously inspected special materials and technologies in compliance with the ANSI/ISA 71.04-2013 standard to increase system lifetime and ensure product reliability and durability.

In terms of security, Advanced Encryption Standard (AES) ensures data security and provides users with a peace of mind. Furthermore, with End-to-End Data Protection, data integrity can be assured at multiple points in the path to enable reliable delivery of data transfers. Regarding reliability, PV220-M280 is built with a powerful PCIe controller that supports on-the-module ECC as well as efficient wear leveling scheme. In terms of power efficiency, PV220-M280 is compliant with PCIe Gen3 x4 interface standard so that it can operate on power management modes, which greatly save on power consumption.

2. Functional Block

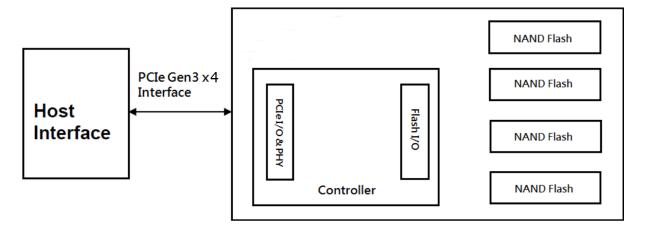


Figure 2-1 Functional Block Diagram

3. Pin Assignments

This connector does not support hot plug capability. There are a total of 75 pins. 12 pin locations are used for mechanical key locations; this allows such a module to plug into Key M connectors.

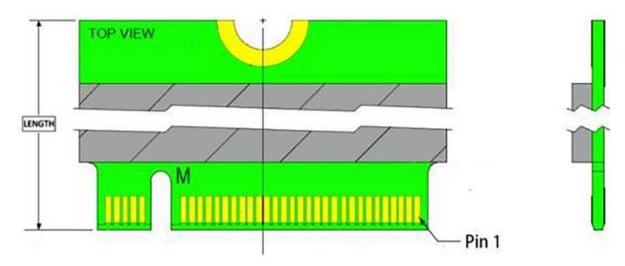


Table 3-1 Pin Assignments

Pin	Туре	Description
1	GND	Ground
2	3.3V	3.3V source
3	GND	Ground
4	3.3V	3.3V source
5	PETn3	PCIe TX Differential signal defined by the PCI Express M.2 spec
6	N/C	No connect*
7	PETp3	PCIe TX Differential signal defined by the PCI Express M.2 spec
8	N/C	No connect*
9	GND	Ground
10	LED1#(O)	Status indicators via LED devices
11	PERn3	PCIe RX Differential signal defined by the PCI Express M.2 spec
12	3.3V	3.3V source
13	PERp3	PCIe RX Differential signals defined by the PCI Express M.2 spec
14	3.3V	3.3V source
15	GND	Ground
16	3.3V	3.3V source
17	PETn2	PCIe TX Differential signal defined by the PCI Express M.2 spec
18	3.3V	3.3V source
19	PETp2	PCIe TX Differential signal defined by the PCI Express M.2 spec
20	N/C	No connect*
21	GND	Ground
22	N/C	No connect*
23	PERn2	PCIe RX Differential signal defined by the PCI Express M.2 spec
24	N/C	No connect*
25	PERp2	PCIe RX Differential signal defined by the PCI Express M.2 spec
26	N/C	No connect*
27	GND	Ground
28	N/C	No connect*
29	PETn1	PCIe TX Differential signal defined by the PCI Express M.2 spec
30	N/C	No connect*
31	PETp1	PCIe TX Differential signal defined by the PCI Express M.2 spec

Table 3-1 Pin Assignments

Din	Time	Pagarintian
Pin	Туре	Description
32	N/C	No connect*
33	GND	Ground
34	N/C	No connect*
35	PERn1	PCIe RX Differential signal defined by the PCI Express M.2 spec
36	N/C	No connect*
37	PERp1	PCIe RX Differential signal defined by the PCI Express M.2 spec
38	N/C	No connect*
39	GND	Ground
40	SMB_CLK	SMBus clock; Open Drain with pull up on platform
41	PETn0	PCIe TX Differential signal defined by the PCI Express M.2 spec
42	SMB_DATA	SMBus Data; Open Drain with pull up on platform
43	PETp0	PCIe TX Differential signal defined by the PCI Express M.2 spec
	·	Alert notification to host system. Open Drain with pull up on platform, Active
44	ALERT#	low Signals
45	GND	Ground
46	N/C	No connect*
47	PERn0	PCIe RX Differential signal defined by the PCI Express M.2 spec
48	N/C	No connect*
49	PERp0	PCIe RX Differential signal defined by the PCI Express M.2 spec
70		PE-Reset is a functional reset to the card as specification. defined by the
50	PERST#(I)(0/3.3V)	PCIe Mini CEM
51	GND	Ground
31		Clock Request is a reference clock request signal as defined by the PCIe
52	CLKREQ#(I/O)(0/3.3V)	Mini CEM specification; Also used by L1 PM Substates.
JZ		PCIe Reference Clock signals (100 MHz) spec. defined by the PCI Express
53	REFCLKn	M.2
54	PEWAKE#(I/O)(0/3.3V)	Open Drain with pull up on platform; Active Low. PCIe PME Wake.
54	FEVVARE#(I/O)(0/3.3V)	
1		LDCIa Dataranca Clack cianale (100 MHz) case datinad by the DCI Evarace
55	REFCLKp	PCIe Reference Clock signals (100 MHz) spec. defined by the PCI Express
55	REFCLKp	M.2
55	REFCLKp Reserved for	M.2 Manufacturing Data line. Used for SSD manufacturing only.
		M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation.
56	Reserved for MFG DATA	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket.
	Reserved for	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground
56	Reserved for MFG DATA GND Reserved for MFG	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only.
56 57	Reserved for MFG DATA GND	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation.
56 57 58	Reserved for MFG DATA GND Reserved for MFG CLOCK	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket.
56 57 58 59	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key
56 57 58 59 60	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key Module Key	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key Module Key
56 57 58 59 60 61	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key Module Key Module Key	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key Module Key Module Key
56 57 58 59 60 61 62	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key Module Key Module Key Module Key Module Key	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key Module Key Module Key Module Key Module Key
56 57 58 59 60 61 62 63	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key
56 57 58 59 60 61 62 63 64	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key
56 57 58 59 60 61 62 63 64 65	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key
56 57 58 59 60 61 62 63 64 65 66	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key
56 57 58 59 60 61 62 63 64 65	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key N/C	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key
56 57 58 59 60 61 62 63 64 65 66	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key SUSCLK(32KHz)	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key No connect* 32.768 kHz clock supply input that is provided by the platform
56 57 58 59 60 61 62 63 64 65 66 67	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key SUSCLK(32KHz) (I)(0/3.3V)	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key No connect* 32.768 kHz clock supply input that is provided by the platform chipset to reduce power and cost for the module.
56 57 58 59 60 61 62 63 64 65 66 67 68	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key SUSCLK(32KHz) (I)(0/3.3V) PEDET (NC-PCIe)	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key No connect* 32.768 kHz clock supply input that is provided by the platform chipset to reduce power and cost for the module. Host I/F Indication; No Connect for PCIe.
56 57 58 59 60 61 62 63 64 65 66 67 68 69 70	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key SUSCLK(32KHz) (I)(0/3.3V) PEDET (NC-PCIe) 3.3V	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key No connect* 32.768 kHz clock supply input that is provided by the platform chipset to reduce power and cost for the module. Host I/F Indication; No Connect for PCIe. 3.3V source
56 57 58 59 60 61 62 63 64 65 66 67 68 69 70 71	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key SUSCLK(32KHz) (I)(0/3.3V) PEDET (NC-PCIe) 3.3V GND	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key No connect* 32.768 kHz clock supply input that is provided by the platform chipset to reduce power and cost for the module. Host I/F Indication; No Connect for PCIe. 3.3V source Ground
56 57 58 59 60 61 62 63 64 65 66 67 68 69 70 71 72	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key SUSCLK(32KHz) (I)(0/3.3V) PEDET (NC-PCIe) 3.3V GND 3.3V	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key Motule Key No connect* 32.768 kHz clock supply input that is provided by the platform chipset to reduce power and cost for the module. Host I/F Indication; No Connect for PCIe. 3.3V source Ground 3.3V source
56 57 58 59 60 61 62 63 64 65 66 67 68 69 70 71 72 73	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key Mo	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key No connect* 32.768 kHz clock supply input that is provided by the platform chipset to reduce power and cost for the module. Host I/F Indication; No Connect for PCle. 3.3V source Ground 3.3V source Ground
56 57 58 59 60 61 62 63 64 65 66 67 68 69 70 71 72	Reserved for MFG DATA GND Reserved for MFG CLOCK Module Key SUSCLK(32KHz) (I)(0/3.3V) PEDET (NC-PCIe) 3.3V GND 3.3V	M.2 Manufacturing Data line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Ground Manufacturing Clock line. Used for SSD manufacturing only. Not used in normal operation. Pins should be left N/C in platform Socket. Module Key Motule Key No connect* 32.768 kHz clock supply input that is provided by the platform chipset to reduce power and cost for the module. Host I/F Indication; No Connect for PCIe. 3.3V source Ground 3.3V source

^{*}Reserved by Apacer, please do not connect on a host.

4. Product Specifications

4.1 Capacity

Capacity specifications of PV220-M280 are available as shown in Table 4-1. It lists the specific capacity and the default numbers of heads, sectors and cylinders for each product line.

Table 4-1 Capacity Specifications

Capacity	Total bytes*	Total LBA
120 GB	120,034,123,776	234,441,648
240 GB	240,057,409,536	468,862,128
480 GB	480,103,981,056	937,703,088
960 GB	960,197,124,096	1,875,385,008
1,920 GB	1,920,383,410,176	3,750,748,848

^{*}Display of total bytes varies from file systems, which means not all of the bytes can be used for storage.

LBA count addressed in the table above indicates total user storage capacity and will remain the same throughout the lifespan of the device. However, the total usable capacity of the SSD is most likely to be less than the total physical capacity because a small portion of the capacity is reserved for device maintenance usages.

4.2 Performance

Performance of PV220-M280 is listed below in Table 4-2.

Table 4-2 Performance Specifications

Capacity Performance	120 GB	240 GB	480 GB	960 GB	1,920 GB
Sequential Read* (MB/s)	1,460	1,645	1,690	1,680	1,710
Sequential Write* (MB/s)	520	1,040	1,605	1,660	1,685
Random Read IOPS** (4K)	77,000	152,000	217,000	222,000	209,000
Random Write IOPS** (4K)	103,000	186,000	261,000	263,000	230,000

Note:

Results may differ from various flash configurations or host system setting.

^{**}Notes: 1 GB = 1,000,000,000 bytes; 1 sector = 512 bytes.

^{*}Sequential performance is based on CrystalDiskMark 5.2.1 with file size 1,000MB.

^{**}Random performance measured using IOMeter with Queue Depth 64.

4.3 Environmental Specifications

Environmental specifications of PV220-M280 are shown in Table 4-3.

Table 4-3 Environmental Specifications

Item	Specifications
Operating temp.	0°C to 70°C (Standard); -40°C to 85°C (Wide)
Non-operating temp.	-40°C to 100°C
Operating vibration	7.69 GRMS, 20~2000 Hz/random (compliant with MIL-STD-810G)
Non-operating vibration	4.02 GRMS, 15~2000 Hz/random (compliant with MIL-STD-810G)
Operating shock	50(G)/11ms/half sine (compliant with MIL-STD-202G)
Non-operating shock	1,500(G)/0.5(ms)/half sine (compliant with MIL-STD-883K)

Note: Shock and Vibration specifications are subject to change without notice.

4.4 Mean Time Between Failures (MTBF)

Mean Time Between Failures (MTBF) is predicted based on reliability data for the individual components in PV220-M280. The prediction result for PV220-M280 is more than 3,000,000 hours.

Note: The MTBF is predicated and calculated based on "Telcordia Technologies Special Report, SR-332, Issue 3" method.

4.5 Certification and Compliance

PV220-M280 complies with the following standards:

- CE
- FCC
- RoHS
- MIL-STD-810G

4.6 Endurance

The endurance of a storage device is predicted by Drive Writes Per Day based on several factors related to usage, such as the amount of data written into the drive, block management conditions, and daily workload for the drive. Thus, key factors, such as Write Amplifications and the number of P/E cycles, can influence the lifespan of the drive.

Table 4-4 Drive Writes Per Day

Capacity	Drive Writes Per Day
120 GB	3.45
240 GB	3.09
480 GB	2.83
960 GB	2.9
1,920 GB	2.81

Note:

- This estimation complies with JEDEC JESD-219, enterprise endurance workload of random data with payload size distribution.
- Flash vendor guaranteed 3D NAND TLC P/E cycle: 3K
- WAF may vary from capacity, flash configurations and writing behavior on each platform.
- 1 Terabyte = 1,024GB
- DWPD (Drive Writes Per Day) is calculated based on the number of times that user overwrites
 the entire capacity of an SSD per day of its lifetime during the warranty period. (3D NAND TLC
 warranty: 2 years)

4.7 LED Indicator Behavior

The behavior of the PV220-M280 LED indicators is described in Table 4-5.

Table 4-5 LED Behavior

Location	LED	Description
LED A	DAS	LED blinks when the drive is being accessed



5. Flash Management

5.1 Error Correction/Detection

PV220-M280 implements a hardware ECC scheme, based on the Low Density Parity Check (LDPC). LDPC is a class of linear block error correcting code which has apparent coding gain over BCH code because LDPC code includes both hard decoding and soft decoding algorithms. With the error rate decreasing, LDPC can extend SSD endurance and increase data reliability while reading raw data inside a flash chip.

5.2 Bad Block Management

Current production technology is unable to guarantee total reliability of NAND flash memory array. When a flash memory device leaves factory, it comes with a minimal number of initial bad blocks during production or out-of-factory as there is no currently known technology that produce flash chips free of bad blocks. In addition, bad blocks may develop during program/erase cycles. Since bad blocks are inevitable, the solution is to keep them in control. Apacer flash devices are programmed with ECC, page mapping technique and S.M.A.R.T to reduce invalidity or error. Once bad blocks are detected, data in those blocks will be transferred to free blocks and error will be corrected by designated algorithms.

5.3 Global Wear Leveling

Flash memory devices differ from Hard Disk Drives (HDDs) in terms of how blocks are utilized. For HDDs, when a change is made to stored data, like erase or update, the controller mechanism on HDDs will perform overwrites on blocks. Unlike HDDs, flash blocks cannot be overwritten and each P/E cycle wears down the lifespan of blocks gradually. Repeatedly program/erase cycles performed on the same memory cells will eventually cause some blocks to age faster than others. This would bring flash storages to their end of service term sooner. Global wear leveling is an important mechanism that levels out the wearing of all blocks so that the wearing-down of all blocks can be almost evenly distributed. This will increase the lifespan of SSDs.

5.4 DataDefender™

Apacer's DataDefender combines both firmware and hardware mechanisms to ensure data integrity. When power disruption occurs, the hardware mechanism will notice and trigger the controller to run multiple write-to-flash cycles to store data. Then the firmware will check that the data was correctly written to the NAND flash after the power disruption, preventing data loss.

5.5 TRIM

TRIM is a feature which helps improve the read/write performance and speed of solid-state drives (SSD). Unlike hard disk drives (HDD), SSDs are not able to overwrite existing data, so the available space gradually becomes smaller with each use. With the TRIM command, the operating system can inform the SSD which blocks of data are no longer in use and can be removed permanently. Thus, the SSD will perform the erase action, which prevents unused data from occupying blocks all the time.

5.6 Flash Translation Layer – Page Mapping

Page mapping is an advanced flash management technology whose essence lies in the ability to gather data, distribute the data into flash pages automatically, and then schedule the data to be evenly written. Page-level mapping uses one page as the unit of mapping. The most important characteristic is that each logical page can be mapped to any physical page on the flash memory device. This mapping algorithm allows different sizes of data to be written to a block as if the data is written to a data pool and it does not need to take extra operations to process a write command. Thus, page mapping is adopted to increase random access speed and improve SSD lifespan, reduce block erase frequency, and achieve optimized performance and lifespan.

5.7 Hyper Cache Technology

Apacer proprietary Hyper Cache technology uses a portion of the available capacity as SLC (1bit-percell) NAND flash memory, called Hyper cache mode. When data is written to SSD, the firmware will direct the data to Hyper Cache mode, providing excellent performance to handle various scenarios in industrial use.

5.8 Over-Provisioning

Over-Provisioning (OP) is a certain portion of the SSD capacity exclusively for increasing Garbage Collection (GC) efficiency, especially when the SSD is filled to full capacity or performs a heavy mixed-random workload. OP has the advantages of providing extended life expectancy, reliable data integrity, and high sustained write performance.

5.9 DataRAID™

Apacer's DataRAID algorithm applies an additional level of protection and error-checking. Using this algorithm, a certain amount of space is given over to aggregating and resaving the existing parity data used for error checking. So, in the event that data becomes corrupted, the parity data can be compared to the existing uncorrupted data and the content of the corrupted data can be rebuilt.

5.10 NVMe Secure Erase

NVMe Secure Erase is an NVMe drive sanitize command currently embedded in most of the storage drives. Defined in NVMe specifications, NVMe Secure Erase is part of Format NVM command that allows storage drives to erase all user data areas. The erase process usually runs on the firmware level as most of the NVMe-based storage media currently in the market are built-in with this command. NVMe Secure Erase can securely wipe out the user data in the drive and protects it from malicious attack.

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6. NVMe Support Features

6.1 Host Memory Buffer

Host Memory Buffer (HMB) allows HOST to allocate system memory for SSD's exclusive use in order to provide better performance and endurance, especially for DRAMless solutions.

7. Security & Reliability Features

7.1 Anti-Sulfuration

Apacer's awarded patent for anti-sulfuration products adopts exclusive and improved alloy materials to protect silver in the electrode from reacting with sulfur to produce silver sulfide and cause an increase in resistance. This technology not only effectively solves corrosion problems caused by environmental pollution but also increases overall system lifespan and allows stable system operation over long hours in a harsh environment, ensuring product reliability and durability.

Apacer's anti-sulfuration SSDs achieve a complete air barrier through strict inspection of special materials and technologies. After two complete accelerated verification tests of MFG (Mixed Fluid Gas) and FoS (Flower of Sulfur), it has passed the American National Standards Institute/International Association of Automation 71.04 G3 air corrosion certification. This proves that it has reached the industry's highest level of sulfur resistance, including resistance to silver corrosion, copper corrosion and creep.

7.2 Advanced Encryption Standard

Advanced Encryption Standard (AES) is a specification for the encryption of electronic data. AES has been adopted by the U.S. government since 2001 to protect classified information and is now widely implemented in embedded computing applications. The AES algorithm used in software and hardware is symmetric so that encrypting/decrypting requires the same encryption key. Without the key, the encrypted data is inaccessible to ensure information security.

Notably in flash memory applications, AES 256-bit hardware encryption is the mainstream to protect sensitive or confidential data. The hardware encryption provides better performance, reliability, and security than software encryption. It uses a dedicated processor, which is built inside the controller, to process the encryption and decryption. This enormously shortens the processing time and makes it efficient.

7.3 Thermal Sensor

Apacer Thermal Sensor is a digital temperature sensor with serial interface. By using designated pins for transmission, storage device owners are able to read temperature data.

7.4 Thermal Throttling

Thermal throttling can monitor the temperature of the SSD equipped with a built-in thermal sensor via S.M.A.R.T. commands. This method can ensure the temperature of the device stays within temperature limits by drive throttling, i.e. reducing the speed of the drive when the device temperature reaches the threshold level, so as to prevent overheating, guarantee data reliability, and prolong product lifespan. When the temperature exceeds the maximum threshold level, thermal throttling will be triggered to reduce performance step by step to prevent hardware components from being damaged. Performance is only permitted to drop to the extent necessary for recovering a stable temperature to cool down the device's temperature. Once the temperature decreases to the minimum threshold value, transfer speeds will rise back to its optimum performance level.

7.5 End-to-End Data Protection

End-to-End Data Protection is a feature implemented in Apacer SSD products that extends error control to cover the entire path from the host computer to the drive and back, and that ensures data integrity at multiple points in the path to enable reliable delivery of data transfers. Unlike ECC which does not exhibit the ability to determine the occurrence of errors throughout the process of data transmission, End-to-End Data Protection allows SSD controller to identify an error created anywhere in the path and report the error to the host computer before it is written to the drive. This error-checking and error-reporting mechanism therefore guarantees the trustworthiness and reliability of the SSD.

7.6 CoreGlacier™

In many applications, SSDs are subject to challenging conditions. If the working environment is already hot, and the SSD's operation causes it to increase in temperature as well, the result could be damage to the hardware or corrupted data. In cases like this, leading industrial manufacturers know to turn to Apacer. Apacer developed CoreGlacier, a heatsink that distributes dissipation in isolated components with no thermal diffusion, to prevent heat-related damage from occurring.

8. Software Interface

8.1 Command Set

Table 8-1 summarizes the commands supported by PV220-M280.

Table 8-1 Admin Commands

Opcode	Command Description
00h	Delete I/O Submission Queue
01h	Create I/O Submission Queue
02h	Get Log Page
04h	Delete I/O Completion Queue
05h	Create I/O Completion Queue
06h	Identify
08h	Abort
09h	Set Features
0Ah	Get Features
0Ch	Asynchronous Event Request
10h	Firmware Activate
11h	Firmware Image Download
14h	Device Self-test

Table 8-2 Admin Commands – NVM Command Set Specific

Opcode	Command Description
80h	Format NVM
84h	Sanitize

Table 8-3 NVM Commands

Opcode	Command Description
00h	Flush
01h	Write
02h	Read
04h	Write Uncorrectable
05h	Compare
08h	Write Zeroes
09h	Dataset Management

8.2 S.M.A.R.T.

SMART, an acronym for Self-Monitoring, Analysis and Reporting Technology, is an open standard that allows a hard disk drive to automatically detect its health and report potential failures. When a failure is recorded by SMART, users can choose to replace the drive to prevent unexpected outage or data loss. Moreover, SMART can inform users of impending failures while there is still time to perform proactive actions, such as copy data to another device.

Table 8-4 SMART (02h)

Byte	Length	Description		
0	1	Critical Warning		
1-2	2	Composite Temperature (PCB Sensor)		
3	1	Available Spare		
4	1	Available Spare Threshold		
5	1	Percentage Used (Average Erase Count / P/E Cycle Count)		
6-31	26	Reserved		
32-47	16	Data Units Read		
48-63	16	Data Units Written		
64-79	16	Host Read Commands		
80-95	16	Host Write Commands		
96-111	16	Controller Busy Time		
112-127	16	Power Cycles		
128-143	16	Power On Hours		
144-159	16	Unsafe Shutdowns		
160-175	16	Media and Data Integrity Errors		
176-191	16	Number of Error Information Log Entries		
192-195	4	Warning Composite Temperature Time		
196-199	4	Critical Composite Temperature Time		
200-201	2	Temperature Sensor 1: Controller Temperature		
202-203	2	Temperature Sensor 2: PCB Temperature		
204-205	2	Temperature Sensor 3: NAND Flash Temperature		
206-207	2	Temperature Sensor 4		
208-209	2	Temperature Sensor 5		
210-211	2	Temperature Sensor 6		
212-213	2	Temperature Sensor 7		
214-215	2	Temperature Sensor 8		
216-511	296	Reserved		

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Table 8-5 SMART (C0h)

Byte	Length	Description		
0-255	256	Reserved		
256-257	2	SSD Protect Mode		
258-261	4	Host Read UNC Count		
262-265	4	PHY Error Count		
266-269	4	CRC Error Count		
270-273	4	Total Early Bad Block Count		
274-277	4	Total Later Bad Block Count		
278-281	4	Max Erase Count		
282-285	4	Average Erase Count		
286-289	4	Program Fail Count		
290-293	4	Erase Fail Count		
294-301	8	Flash Write Sector		
302-305	4	Total Spare Block		
306-309	4	Current Spare Block		
310-313	4	Read Retry Count		
314-511	210	Reserved		

9. Electrical Specifications

9.1 Operating Voltage

Table 9-1 lists the supply voltage for PV220-M280.

Table 9-1 Operating Range

Item	Range
Supply Voltage	$3.3V \pm 5\%$

9.2 Power Consumption

Table 9-2 lists the power consumption for PV220-M280.

Table 9-2 Power Consumption

Capacity Mode	120 GB	240 GB	480 GB	960 GB	1,920 GB
Active (mA)	965	1,060	1,165	1,270	1,320
Idle (mA)	240	240	240	240	245

^{*}All values are typical and may vary depending on flash configurations or host system settings.

**Active power is an average power measurement performed using CrystalDiskMark with 128KB sequential read/write transfers.

10. Physical Characteristics

10.1 Single Side

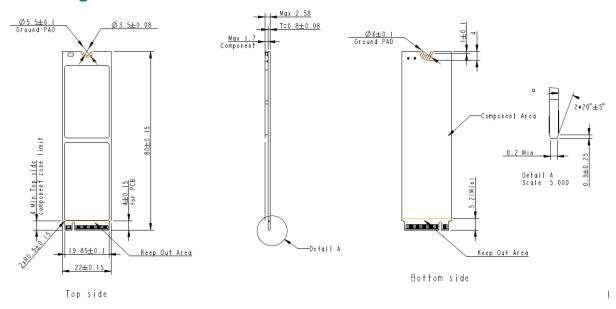


Figure 10-1 Dimensions - Single Side

10.2 Double Side

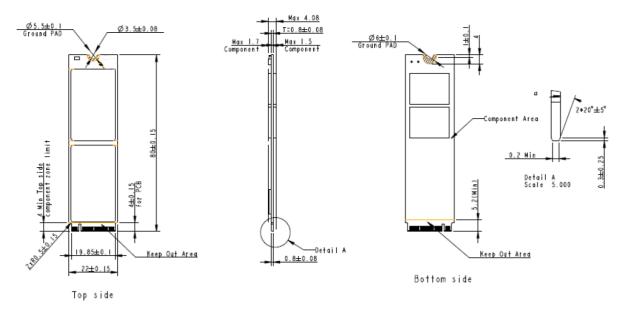


Figure 10-2 Dimensions - Double Side

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10.3 Net Weight

Table 10-1 Net Weight

Capacity	Net Weight (g ± 5%)
120GB	6.53
240GB	7.28
480GB	7.23
960GB	7.59
1,920GB	7.7

11. Product Ordering Information

11.1 Product Code Designations

Codo	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
Coue	В	9	2		2	2	5	Χ	Χ	Χ		Χ	Χ	Χ	0	5

Code 1-3 (Product Line & Form Factor)	PCIe + M280
Code 5-6 (Model/Solution)	PV220-M280
Code 7-8 (Product Capacity)	5H: 120GB 5J: 240GB 5K: 480GB 5L: 960GB 5M: 1,920GB
Code 9 (Flash Type & Product Temp)	G: 3D TLC Standard temperature H: 3D TLC Wide temperature
Code 10 (Product Spec)	V: Single side M key with Graphene U:Double side M key with Graphene
Code 12-14 (Version Number)	Random numbers generated by system
Code 15-16 (Firmware Version)	05: Thermal Sensor

11.2 Valid Combinations

Capacity	Standard Temperature	Wide Temperature
120GB	B92.225HGV.00205	B92.225HHV.00205
240GB	B92.225JGU.00205	B92.225JHU.00205
480GB	B92.225KGU.00205	B92.225KHU.00205
960GB	B92.225LGU.00205	B92.225LHU.00305
1,920GB	B92.225MGU.00205	B92.225MHU.00205

Note: Valid combinations are those products in mass production or will be in mass production. Consult your Apacer sales representative to confirm availability of valid combinations and to determine availability of new combinations.

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Revision History

Revision	Description	Date
0.1	Preliminary release	6/15/2021
1.0	Official release	6/22/2021

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MTFDKBZ3T8TFR-1BC1ZABYY MTFDKBA800TFS-1BC1ZABYY SQF-SMSZ2-64GCSBC B92.225HGV.00205 APM128GMFFN-6BTM1GW MTFDDAK060MBD-1AH12ITYY MTFDDAK960MBP-1AN16ABYY VSF202PC016G-100 AF512GSMEL-VABIP FFD-25-SATA-1-A 2400022 2913199 2701112 MTFDDAV512TBN-1AR1ZABYY SSDPEKKA256G801 2400338 2400335 MTFDDAV256TBN-1AR12ABYY SSDPEKKA020T801 MTFDDAK064MBD-1AH12ITYY MTFDDAK800MBP-1AN1ZABYY EP-SSMSF128AACS SQF-S25U8-128G-SAE A52.255LHB.00246 AP-FD25C23E0064GS-5TM AP-FD25C23E0128GS-W5TM AP-FM008GD2505S-TW1M AP-FM008GD2505S-T1H APM256GMFFN-4BTM1GW APM2T42SM22032GFN-4FTM APM2T80SM21256GAS-4BTMG APS297F064G-4BTM1GF APM016GNEAN-4ETM1 AF8GSSHI-VACXP AF32GSMEL-VAEIP AF256GSMEL-VABIP AF16GSSIA-VAAXP AF32GSSHI-VACXP AF240GSTIC-7BEXP AF480GSTJA-8BEIX GLS86FP512G3-I-BZ000 GLS87BP001T3-C-BZ200